Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10519564	SAITO, TAKESHI
Examiner	Art Unit
Chen, Junpeng	2618

SEARCHED					
Class	Subclass	. Date	Examiner		
455	556.1,344,557,572	12/05/2006	J.C.		
340	10.1-10.3,572.4,10.5	12/05/2006	J.C.		
342	44,193	12/05/2006	J.C.		
375	300,268	12/05/2006	J.C.		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	12/05/2006	J.C.		
Consulted Edan, Orgad, Quochien Voung on Claims 10	12/15/2006	J.C.		
Consulted Lewis West	12/15/2006	J.C.		

Examine
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